## Application/Control No. Applicant(s)/Patent Under Reexamination 10/023,886 SHIMAZU, HIDEO **Notice of References Cited** Art Unit Examiner Page 1 of 1 DANIEL LASTRA 3622 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,848,373	12-1998	DeLorme et al.	701/200
	В	US-			
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	D	US-			
	E	US-			
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## **NON-PATENT DOCUMENTS**

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